

1	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/564,444	MEGED, DAVID	
	Examiner	Art Unit	
	Tejash D. Patel	3765	

	SEARCHED				
Class	Subclass	Date	Examiner		
2	69	1/16/2008	TP		
	81, 93				
	94				
	87				
	97				
	272				
	904				
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
PALM Searched	1/16/2008	TP			